# SN5433, SN54LS33, SN7433, SN74LS33 QUADRUPLE 2-INPUT POSITIVE NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

**SDLS101** 

DECEMBER 1983-REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

## description

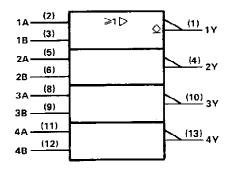
These devices contain four independent 2-input NOR buffer gates with open-collector outputs. Open-collector outputs require resistive pull-up to perform logically but can deliver higher VOH levels and are commonly used in wired-AND applications.

The SN5433 and SN54LS33 are characterized for operation over the full military temperature range of  $-55\,^{\circ}\text{C}$  to 125 $\,^{\circ}\text{C}$ . The SN7433, and SN74LS33 are characterized for operation from 0 $\,^{\circ}\text{C}$  to 70 $\,^{\circ}\text{C}$ .

#### **FUNCTION TABLE (each gate)**

INP	UTS	OUTPUT
Α	В	Y
Н	х	L
×	Н	L
L	L	H

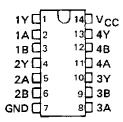
## logic symbol†



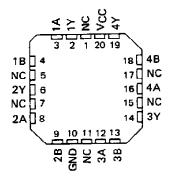
 $<sup>^\</sup>dagger$  This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

SN5433, SN54LS33...J OR W PACKAGE SN7433...N PACKAGE SN74LS33...D OR N PACKAGE (TOP VIEW)

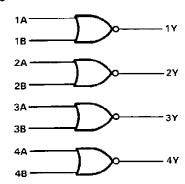


SN54LS33 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

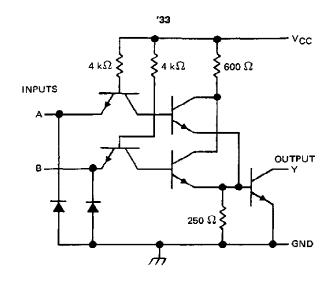
## logic diagram

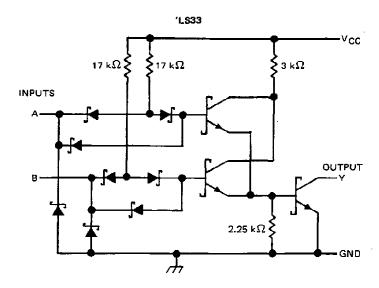


#### positive logic

 $Y = \overline{A + B} \text{ or } Y = \overline{A \cdot B}$ 

schematics (each gate)





Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)
Input voltage: '33 5.5 V
'L\$33 7 V
Off-state output voltage
Operating free-air temperature: SN54'55°C to 125°C
SN74' 0°C to 70°C
Storage temperature range
NOTE 1: Voltage values are with respect to network ground terminal.

# SN5433, SN7433 QUADRUPLE 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

## recommended operating conditions

			SN5433			SN7433			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
ViH	High-level input voltage	2			2			V	
۷IL	Low-level input voltage			0.8			0.8	٧	
Vон	High-level output voltage			5.5			5.5		
loL	Low-level output current			48			48	mA	
TA	Operating free-air temperature	- 55		125	0		70	°C	

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN543					
	TEST CONDITIONS.	MIN TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA		-1.5			- 1.5	V
	$V_{CC} = MIN, V_{IL} = 0.8 \text{ V}, V_{OH} = 5.5 \text{ V}$					0.25	
ф	$V_{CC} = MIN, V_{IL} = 0.7 \text{ V}, V_{OH} = 5.5 \text{ V}$		0.25				mA
VOL	V <sub>CC</sub> = MIN. V <sub>IH</sub> ≈ 2 V, I <sub>OL</sub> = 16 mA	0.2	0.4		0.2	0.4	~
	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V		1			1	mΑ
l <sub>IH</sub>	$V_{CC} = MAX$ , $V_1 = 2.4 V$		40			40	μА
IIL.	$V_{CC} = MAX$ , $V_1 = 0.4 V$		1.6			- 1.6	mA
ІССН	VCC = MAX, VI = 0	3	6		3	6	mA
ICCL	V <sub>CC</sub> = MAX, See Note 2	9	16.5		9	16.5	mA

<sup>\*</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25 \,^{\circ}\text{C}$ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH	<del></del>		$R_{l} = 133 \text{ k}\Omega,  C_{l} = 50 \text{ pF}$		10	15	กร
†PHL	A or B		n <sub>L</sub> = 133 kπ, c <sub>L</sub> = 50 pr		12	18	ns
tPLH t	AUID	'	$R_1 = 133 \text{ k}\Omega,  C_1 = 150 \text{ pF}$	L	15	22	пs
<sup>t</sup> PHL			ng = 130 kg, Cg = 150 pr		16	24	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

 $<sup>^{\</sup>ddagger}$ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25 °C. NOTE 2: One input at 4.5 V, all others at 0 V.

# SN54LS33, SN74LS33 QUADRUPLE 2-INPUT POSITIVE NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

#### recommended operating conditions

· ·	S	SN54L\$33			SN74LS33			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
V <sub>1H</sub> High-level input voltage	2			2			V	
VIL Low-level input voltage			0,7			8.0	V	
VOH High-level output voltage			5.5			5.5	V	
IOL Low-level output current			12			24	mΑ	
TA Operating free-air temperature	- 55		125	0		70	°C	

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †			SN54LS33			SN74LS33			UNIT	
PARAMETER				MIN	TYP‡	MAX	MIN	TYP ‡	MAX	UNII	
VIK	VCC = MIN,	I <sub>I</sub> = - 18 mA					- 1.5			- 1.5	V
10н	VCC = MIN,	V <sub>IH</sub> = 2 V,	VIL = MAX,	V <sub>OH</sub> = 5.5 V			0.25			0.25	mΑ
V.	V <sub>CC</sub> = MIN.	V <sub>IH</sub> = 2 V,	V <sub>IL</sub> = MAX,	OL = 12 mA		0.25	0.4		0.25	0.4	1
VOL	V <sub>CC</sub> = MIN,	VIL = MAX,	I <sub>OL</sub> = 24 mA						0.35	0.5	٧
Ц	VCC = MAX.	V <sub>1</sub> = 7 V					0.1			0.1	mA
liH.	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.7 V					20			20	μА
IL	VCC = MAX,	V1 = 0.4 V					<b>- 0,4</b>			- 0.4	mA
ГССН	V <sub>CC</sub> = MAX.	V <sub>1</sub> = 0				1.8	3.6		1.8	3.6	mA
ICCL	VCC = MAX,	See Note 2				6.9	13.8		6.9	13.8	mA

<sup>&</sup>lt;sup>†</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics, VCC = 5 V, TA = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH .	A or B	V	$R_1 \approx 667  \Omega$ , $C_L = 45  pF$		20	32	ns
t₽HL	N 51 D				18	28	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

 $<sup>^{\</sup>ddagger}$  All typical values are at VCC = 5 V, TA = 25 °C. NOTE 2: One input at 4.5 V, all others at 0 V.

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